CE

VERIFICATION OF COMPLIANCE

This Verification of Compliance is hereby issued to the product designated below.

Product	IPC
Model	ACP-2320
Trade name	ADVANTECH
Applicant	Advantech Co., Ltd. No. 1, Alley 20, Lane 26, Rueiguang Road, Neihu District, Taipei 114, Taiwan, R.O.C.
Applicable Standard(s)	EN 55022: 1998 (Class A) EN 61000-3-2: 2000 EN 61000-3-3: 1995 + A1: 2001 EN 55024: 1998 + A1: 2001 IEC 61000-4-2: 1995 + A2: 2000; IEC 61000-4-3: 1995 + A2: 2000; IEC 61000-4-4: 1995 + A1: 2000; IEC 61000-4-5: 1995 + A1: 2000; IEC 61000-4-6: 1996 + A1: 2000; IEC 61000-4-8: 1993 + A1: 2000 IEC 61000-4-11: 1994 + A1: 2000
Report No.	41022201-Е
Test Laboratory	Compliance Certification Services Inc. No. 81-1, Lane 210, Bade Rd., 2, Luchu Hsiang, Taoyuan Hsien, Taiwan, R.O.C. Tel: +886-3-3240332/ Fax: +886-3-3245235

This device has been tested and found to comply with the stated standard(s), which is(are) required by the Council Directive of 89/336/EEC and Amendment Directive of 93/68/EEC. The test results are indicated in the test report and are applicable only to the tested sample identified in the report.

Cust Clim

Kurt Chen / Director of Linkou Laboratory Date: November 30, 2004



CE EMC

TEST REPORT

For

IPC

Model: ACP-2320

Trade Name: ADVANTECH

Issued for

Advantech Co., Ltd. No. 1, Alley 20, Lane 26, Rueiguang Road, Neihu District, Taipei 114, Taiwan, R.O.C.

Issued by

QALVA

Compliance Certification Services Inc. No. 81-1, Lane 210, Bade Rd., 2, Luchu Hsiang, Taoyuan Hsien, (338) Taiwan, R.O.C. TEL: 886-3-324-0332 FAX: 886-3-324-5235



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1 TEST RESULT CERTIFICATION

Report No.: 41022201-E

Compliance Certification Services Inc.

Applicant:	Advantech Co., Ltd. No. 1, Alley 20, Lane 26, Rueiguang Road, Neihu District, Taipei 114, Taiwan, R.O.C.
Manufacturer:	Advantech Co., Ltd. No. 1, Alley 20, Lane 26, Rueiguang Road, Neihu District, Taipei 114, Taiwan, R.O.C.
Equipment Under Test:	IPC
Trade Name:	ADVANTECH
Model:	ACP-2320
Detailed EUT Description:	See Item 2 of this report
Date of Test:	October 22 ~ November 23, 2004

Applicable Standard	Class/Limit/Criterion	Test Result
EN 55022: 1998	Class A	No non-compliance noted
EN 61000-3-2: 2000	Class D	No non-compliance noted
EN 61000-3-3: 1995 + A1: 2001	Limit	No non-compliance noted
EN 55024: 1998 + A1: 2001, including		
IEC 61000-4-2: 1995 + A2: 2000	Criterion B	No non-compliance noted
IEC 61000-4-3: 1995 + A2: 2000	Criterion A	No non-compliance noted
IEC 61000-4-4: 1995 + A1: 2000	Criterion B	No non-compliance noted
IEC 61000-4-5: 1995 + A1: 2000	Criterion B	No non-compliance noted
IEC 61000-4-6: 1996 + A1: 2000	Criterion A	No non-compliance noted
IEC 61000-4-8: 1993 + A1: 2000	Criterion A	No non-compliance noted
IEC 61000-4-11: 1994 + A1: 2000	Criterion B/C/C	No non-compliance noted
Deviation fro	m Applicable Standard	

According to applicant's declaration, this EUT is a class A product and to be market in industrial environment only.

The above equipment was tested by Compliance Certification Services Inc. for compliance with the requirements set forth in the EMC Directive 89/336/EEC and the technical standards mentioned above. The results of testing in this report apply only to the product/system, which was tested. Other similar equipment will not necessarily produce the same results due to production tolerance and measurement uncertainties.

Approved by:

Kurt Chen Director of Linkou Laboratory Compliance Certification Services Inc.

Reviewed by: Hill Shiau

Section Manager of Linkou Laboratory Compliance Certification Services Inc.



EUT DESCRIPTION 2

Product	IPC				
Trade Name	ADVANTECH				
Model	ACP-2320				
Housing Type	Metal Case				
EUT Power Rating	100-240VAC, 50-	60Hz, 10A			
Power Supply Manufacturer	Zippy Model P2U-6300P				
	EMACS	Model	P2H-6400P		
AC Power Cord Type	Unshielded, 1.8m (Detachable)				
CPU Manufacture	Intel Model P4 3.2GHz				
OSC/Clock Frequencies	133 MHz				
Memory Capacity		Installed	256MB		
CPU Card Manufacturer	ADVANTECH	Model	AIMB-744		
HDD Manufacturer	Quantum	Model	Firball LCT		
FDD Manufacturer	TEAC	Model	FD-235HF		
CD-ROM Manufacturer	ASUS Model SCD-2400				
VGA Card Manufacturer	ADVANTECH Model PCA-5640				
LAN Card Manufacturer	On Board				



I/O Port of EUT

I/O Port Type	Q'TY	TESTED WITH
1. Video Out Port (VGA)	1	1
2. Parallel Port	1	1
3. Serial Port	2	2
4. PS/2 Keyboard	1	1
5. PS/2 Mouse Port	2	2
6. Earphone Port	1	1
7. Microphone Port	1	1
8. LAN Port	2	2
9. USB Port	6	6
10. S-Video Port	1	1



3 TEST METHODOLOGY

3.1 EUT SYSTEM OPERATION

- 1. EMI test software was loaded and executed under "Windows 2000" environment.
- 2. A communicated software was loaded and executed to communicate between EUT and remote side.
- 3. EUT sends and receives data from Notebook PC at remote side via LAN Cable.
- 4. The data was sent to monitor filling the screen with upper case of "H" patterns.
- 5. Test program sequentially exercised all related I/O's of EUT and sent "H" patterns to all applicable output ports of EUT.
- 6. Repeat step 2 to 5

Note: Test program is self-repeating throughout the test.

3.2 DECISION OF FINAL TEST MODE

1. The following test mode(s) were scanned during the preliminary test:

Mode 1

1600 × 1200 Resolution,75Hz with Zippy / P2U-6300P Power Supply

Mode 2

1280 × 1024 Resolution,75Hz with Zippy / P2U-6300P Power Supply

Mode 3

640 × 640 Resolution,75Hz with Zippy / P2U-6300P Power Supply

Mode 4

1600 × 1200 Resolution,75Hz with EMACS / P2H-6400P - Power Supply

Mode 5

1280 × 1024 Resolution,75Hz with EMACS / P2H-6400P - Power Supply

Mode 6

640 × 640 Resolution,75Hz with EMACS / P2H-6400P - Power Supply

2. After the preliminary scan, the following test mode was found to produce the highest emission level.

Mode 1, 4

Then, the EUT configuration and cable configuration of the above highest emission mode was chosen for all final test items.



SETUP OF EQUIPMENT UNDER TEST 4

Setup Diagram

See test photographs attached in Appendix 1 for the actual connections between EUT and support equipment.

Support Equipment

No.	Equipment	Model No.	Serial No.	FCC ID	Trade Name	Data Cable	Power Cord
1.	Monitor	959NF	AQ19H2RT706139P	FCC DoC	SAMSUNG	Shielded, 1.8m with two cores	Unshielded, 1.8m
2.	Modem	DM-1414	304012265	IFAXDM1414	ACEEX	Shielded, 1.4m	Unshielded, 1.8m
3.	Printer	STYLUS C60	DR3K043130	FCC DoC	EPSON	Shielded, 1.8m	Unshielded, 1.8m
4.	PS/2 Keyboard	Y-SP29	YU30272819	FCC DoC	Logitech	Shielded, 1.8m	N/A
5.	PS/2 Mouse	M-S43	LZE93401262	FCC DoC	Logitech	Shielded, 1.8m	N/A
6.	PS/2 Mouse	M-S43	HCA25200436	FCC DoC	Logitech	Shielded, 1.8m	N/A
7.	Mouse	M-MM43	LZE94052791	FCC DoC	Logitech	Shielded, 1.8m	N/A
8.	USB 2.0 External HDD	F12-UF	A0100214-39t0003	FCC DoC	TeraSys	Shielded, 1.8m	N/A
9.	USB 2.0 External HDD	F12-UF	A0100214-39t0001	FCC DoC	TeraSys	Shielded, 1.8m	N/A
10.	USB 2.0 External HDD	F12-UF	A0100214-43b0015	FCC DoC	TeraSys	Shielded, 1.8m	N/A
11.	USB 2.0 External HDD	F12-UF	A0100214-43b0007	FCC DoC	TeraSys	Shielded, 1.8m	N/A
12.	USB 2.0 External HDD	F12-UF	A0100214-43b0004	FCC DoC	TeraSys	Shielded, 1.8m	N/A
13.	USB 2.0 External HDD	F12-UF	A0100214-43b0010	FCC DoC	TeraSys	Shielded, 1.8m	N/A
14.	Multimedia Earphone	Axis-301	N/A	FCC DoC	Labtec	Unshielded, 1.8m	N/A
15.	V8	DCR-TRV320	N/A	FCC DoC	SONY	S-Video Cable Unshielded, 1.2m	N/A
16.	HUB (Remote)	DS104	N/A	FCC DoC	NERGEAR	LAN Cable: Unshielded, 10m	Unshielded, 1.8m
17.	Notebook PC (Remote)	PPT	0932RY	E2K24GBRL	DELL	LAN Cable: Unshielded, 1m	AC I/P: Unshielded, 1.8m DC O/P: Unshielded, 1.8m

Note: All the above equipment/cables were placed in worse case positions to maximize emission signals during emission test.

Grounding: Grounding was in accordance with the manufacturer's requirements and conditions for the intended use.

5 FACILITIES AND ACCREDITATIONS

5.1 FACILITIES

All measurement facilities used to collect the measurement data are located at CCS Taiwan Linkou Lab at No. 81-1, Lane 210, Bade Rd., 2, Luchu Hsiang, Taoyuan Hsien, Taiwan.

The measurement facilities are constructed in conformance with the requirements of CISPR 16-1, ANSI C63.4 and other equivalent standards.



5.2 LABORATORY ACCREDITATIONS AND LISTINGS

The test facilities used to perform Electromagnetic compatibility tests are registered or accredited by the organizations listed in the following table which includes the recognized scope specifically.

Country	Agency	Scope of Accreditation	Logo
USA	NVLAP	EN 55011, EN 55014-1, AS/NZS 1044, CNS 13783-1, EN 55022, CNS 13438, EN 61000-3-2, EN 61000-3-3, ANSI C63.4, FCC OST/MP-5, AS/NZS CISPR 22, IEC 61000-4-2, IEC 61000-4-3, IEC 61000-4-4, IEC 61000-4-5, IEC 61000-4-6, IEC 61000-4-8, IEC 61000-4-11	NVLAD Late. Costa: 200600-0
USA	FCC	3/10 meter Open Area Test Sites to perform FCC Part 15/18 measurements	FC 93105, 90471
Japan	VCCI	3/10 meter Open Area Test Sites and conducted test sites to perform radiated/conducted measurements	VCCI R-393/1066/725/879/1868 C-402/747/912
Norway	NEMKO	EN 50081-1/2, EN 50082-1/2, IEC 61000-6-1/2, EN 50091-2, EN 50130-4, EN 55011, EN 55013, EN 55014-1/2, EN 55015, EN 55022, EN 55024, EN 61000-3-2/3, EN 61326-1, IEC 61000-4-2/3/4/5/6/8/11, EN 60601-1-2, EN 300 328-2, EN 300 422-2, EN 301 419-1, EN 301 489-01/03/07/08/09/17, EN 301 419-2/3, EN 300 454-2, EN 301 357-2	ELA 124a ELA 124b ELA 124c
Taiwan	CNLA	EN 300 328-1, EN 300 328-2, EN 300 220-1, EN 300 220-2, EN 300 220-3, 47 CFR FCC Part 15 Subpart C, EN 61000-3-2, EN 61000-3-3, CNS 13439, CNS 13783-1, CNS 14115, CNS 13438, AS/NZS CISPR 22, CNS 13022-1, IEC 61000-4-2/3/4/5/6/8/11, CNS 13022-2/3	0 3 6 3 ILAC MRA
Taiwan	BSMI	CNS 13438, CNS 13783-1, CNS 13439, CNS 14115	SL2-IS-E-0014 / IN-E-0014 /A1-E-0014 /R1-E-0014 /R2-E-0014 /L1-E-0014
Canada	Industry Canada	RSS212, Issue 1	Canada IC 3991-3 IC 3991-4

Note: No part of this report may be used to claim or imply product endorsement by CNLA, NVLAP or other government agency.

6 INSTRUMENT AND CALIBRATION

6.1 MEASURING INSTRUMENT CALIBRATION

The measuring equipment utilized to perform the tests documented in this report has been calibrated once a year or in accordance with the manufacturer's recommendations, and is traceable under the IEC 17025 to international or national standards. Equipment has been calibrated by accredited calibration laboratories.

6.2 TEST AND MEASUREMENT EQUIPMENT

The following list contains measurement equipment used for testing. The equipment conforms to the requirement of CISPR 16-1, ANSI C63.2 and other required standards.

Calibration of all test and measurement, including any accessories that may effect such calibration, is checked frequently to ensure the accuracy. Adjustments are made and correction factors are applied in accordance with the instructions contained in the respective manual.

Conducted Emission Test Site # 3						
Name of EquipmentManufacturerModelSerial NumberCalibration Due						
EMI Test Receiver	R&S	ESCS30	845552/030	03/14/2005		
LISN	R&S	ESH2-Z5	843285/010	01/08/2005		
LISN	EMCO	3825/2	9003-1628	07/26/2005		
ISN	FCC	FCC-TLISN-T4	20065	04/30/2005		

Equipment Used for Emission Measurement

Note: The measurement uncertainty is less than +/- 2.83dB, which is evaluated as per the NAMAS NIS 81 and CISPR/A/291/CDV.

Open Area Test Site # 2						
Name of Equipment	Manufacturer	Model	Serial Number	Calibration Due		
Spectrum Analyzer	ADVANTEST	R3261A	21720279	N.C.R		
EMI Test Receiver	SCHAFFNER	SCR 3501	412	01/29/2005		
Pre-Amplifier	HP	8447D	2944A08780	07/14/2005		
Bilog Antenna	SCHWAZBECK	VULB9163	147	12/11/2004		
Turn Table	Chance Most	CM-T003-1	Т807-6	N.C.R		
Antenna Tower	Chance Most	CM-A003-1	A807-6	N.C.R		
Controller	Chance Most	N/A	N/A	N.C.R		
RF Switch	ANRITSU	MP59B	M76890	N.C.R		
Site NSA	C&C Lab.	N/A	N/A	08/13/2005		

Note: The measurement uncertainty is less than +/- 3.36dB, which is evaluated as per the NAMAS NIS 81 and CISPR/A/291/CDV.



Power Harmonic & Voltage Fluctuation/Flicker Measurement (EN 61000-3-2&-3-3)						
Name of EquipmentManufacturerModelSerial NumberCalibration Due						
HARMONICS SYSTEM	EMC-PARTNER	HARMONICS-1 000	094	10/26/2005		

Equipment Used for Immunity Measurement

ESD Test Site (IEC/EN 61000-4-2)						
Name of EquipmentManufacturerModelSerial NumberCalibration Due						
ESD Generator	EM TEST	P30C	0603-01	08/01/2005		

Radiated Electromagnetic Field Immunity Test Site (IEC/EN 61000-4-3)							
Name of Equipment	Manufacturer	Model	Serial Number	Calibration Due			
S.G.	R&S SMY02		100094	08/05/2005 08/06/2005			
Power Meter	R&S	R&S NRVD					
Power Sensor	R&S	R&S URV5-Z2	835640/015	08/06/2005			
Power Sensor	R&S	URV5-Z2	835640/016	08/06/2005			
Power Amplifier	ar	150W1000	300300	N.C.R			

Fast Transients/Burst Test Site (IEC/EN 61000-4-4)						
Name of Equipment	EquipmentManufacturerModelSerial Number		Calibration Due			
Fast Transients/Burst Generator	HAEFELY TRENCH	PEFT- JUNIOR	583 333-117	08/25/2005		
Clamp	Clamp HAEFELY TRENCH		080 421.13	N.C.R		

Surge Immunity Test Site (IEC/EN 61000-4-5)						
Name of Equipment	Manufacturer	Model	Serial Number	Calibration Due		
Surge Tester HAEFELY TRENCH		PSUGER 4010	583 334-71	08/25/2005		

CS Test Site (IEC/EN 61000-4-6)							
Name of Equipment Manufacture		Model	Serial Number	Calibration Due			
S.G.	R&S	SMY02	100094	08/05/2005			
Power Meter	R&S	NRVD	837794/029	08/06/2005			
Power Sensor	Power Sensor R&S		835640/015	08/06/2005			
Power Sensor	R&S	URV5-Z2	835640/016	08/06/2005 N.C.R 03/03/2005 08/06/2005			
Power Amplifier	ar	500A100A	300299				
CDN	Lüthi	801-M3	1879				
CDN	FRANKONIA	CDN-M2	A3002010				
CDN	CDN SCHAFFNER		16906	12/28/2004			

Power Frequency Magnetic Field Immunity Test Site (IEC/EN 61000-4-8)							
Name of Equipment	Manufacturer	Model	Serial Number	· Calibration Due			
TRIAX ELF Magnetic Field Meter	F.W.BELL	4090	9711	11/13/2004			
Clamp Meter	National	300K	11-5980 K	12/04/2004			
Magnetic Field Tester	HAEFELY TRENCH	MAG 100.1	080 938-01	N.C.R			

Voltage Dips/Short Interruption and Voltage Variation Immunity Test Site (IEC/EN 61000-4-1						
Name of Equipment Manufactur		Model	Serial Number	Calibration Due		
Dips/Interruption and Variations Simulator	HAEFELY TRENCH	PLINE 1610	080 344-05	04/06/2005		

7 LINE CONDUCTED & RADIATED EMISSION TEST

7.1 LIMIT

Maximum permissible level of Line Conducted Emission

Frequency	Class A	(dBuV)	Class B (dBuV)		
(MHZ)	Quasi-peak Average		Quasi-peak	Average	
0.15 - 0.5	79	66	66 - 56	56 - 46	
0.50 - 5.0	73	60	56	46	
5.0 - 30.0	73	60	60	50	

Note: The lower limit shall apply at the transition frequency.

Maximum permissible level of Common Mode Conducted Emission (Telecommunication Ports)

CLASS A

Frequency	Voltage Li	mit (dBuV)	Current Limit (dBuA)		
(MHZ)	Quasi-peak	Average	Quasi-peak	Average	
0.15 - 0.5	97 – 87	84 - 74	53 - 43	40 - 30	
0.5 - 30.0	87	74	43	30	

Note: The lower limit shall apply at the transition frequency.

CLASS B

Frequency	Voltage Li	mit (dBuV)	Current Limit (dBuA)		
(MHZ)	Quasi-peak	Average	Quasi-peak	Average	
0.15 - 0.5	84 - 74	74 - 64	40 - 30	30 - 20	
0.5 - 30.0	74	64	30	20	

Note: The lower limit shall apply at the transition frequency.

Maximum permissible level of Radiated Emission measured at 10 meter

Frequency	Class A (dBuV/m)	Class B (dBuV/m)	
(MHZ)	Quasi-peak	Quasi-peak	
30 - 230	40	30	
230 - 1000	47	37	

Note: The lower limit shall apply at the transition frequency.

7.2 TEST PROCEDURE OF LINE CONDUCTED EMISSION

Procedure of Preliminary Test

- The EUT was set up as per the test configuration to simulate typical usage per the user's manual. When the EUT is a tabletop system, a wooden table with a height of 0.8 meters is used and is placed on the ground plane as per EN 55022 (see Test Facility for the dimensions of the ground plane used). When the EUT is a floor-standing equipment, it is placed on the ground plane which has a 3-12 mm non-conductive covering to insulate the EUT from the ground plane.
- Support equipment, if needed, was placed as per EN 55022.
- All I/O cables were positioned to simulate typical actual usage as per EN 55022.
- The test equipment EUT installed received AC power, 230VAC/50Hz, through a Line Impedance Stabilization Network (LISN), which supplied power source and was grounded to the ground plane.
- All support equipment received power from a second LISN.
- The EUT test program was started. Emissions were measured on each current carrying line of the EUT using an EMI Test Receiver connected to the LISN powering the EUT.
- The Receiver scanned from 150kHz to 30MHz for emissions in each of the test modes.
- During the above scans, the emissions were maximized by cable manipulation.
- The test mode(s) described in Item 3.2 were scanned during the preliminary test.
- After the preliminary scan, we found the test mode described in Item 3.2 producing the highest emission level.
- The EUT configuration and cable configuration of the above highest emission level were recorded for reference of the final test.

Procedure of Final Test

- EUT and support equipment were set up on the test bench as per the configuration with highest emission level in the preliminary test.
- A scan was taken on both power lines, Line 1 and Line 2, recording at least the six highest emissions. Emission frequency and amplitude were recorded into a computer in which correction factors were used to calculate the emission level and compare reading to the applicable limit. If EUT emission level was less –2dB to the Average limit in Q.P. mode, then the emission signal was re-checked using an Average detector.
- The test data of the worst-case condition(s) was recorded.

Data Sample:

Freq. (MHz)	Q.P. Raw (dBuV)	Average Raw (dBuV)	Q.P. Limit (dBuV)	Average Limit (dBuV)	Q.P. Margin (dB)	Average Margin (dB)	Note
X.XX	43.95		73.00	60.00	-29.05		L1

Freq. = Emission frequency in MHz

Raw dBuV = Uncorrected Analyzer/Receiver reading + Insertion loss of LISN, if it > 0.5 dB Limit dBuV = Limit stated in standard

Limit dDuv = Limit stated in standard Manain dD = Data line in reference to line

Margin dB = Reading in reference to limit

Note = Current carrying line of reading "---" = The emission level complied wit

= The emission level complied with the Average limits, with at least 2dB margin limits, so no further recheck.

Calculation Formula

Margin (dB) = RAW (dBuV) - Limit (dBuV)

7.3 TEST PROCEDURE OF COMMON MODE CONDUCTED EMISSION FOR TELECOMMUNICATION PORT

- Selecting ISN for unscreened cable or a current probe for screened cable to take measurement.
- The port of the EUT was connected to the remote side support equipment through the ISN/Current Probe and communication in normal condition.
- Making a overall range scan by using the test receiver controlled by controller and record at least six highest emissions for showing in the test report.
- Emission frequency and amplitude were recorded into a computer in which correction factors were used to calculate the emission level and compare reading to the applicable limit.
- In case of measuring on the screened cable, the current limit shall be applied, otherwise the voltage limit should be applied.
- The following test mode(s) were scanned during the preliminary test:

Mode 1 10/100 Mbps with Zippy / P2U-6300P Power Supply

Mode 2 10/100 Mbps with EMACS / P2H-6400P - Power Supply

• After the preliminary scan, we found the following test mode(s) producing the highest emission level and test data of the worst case was recorded.

Mode 1, 2

Data Sample:

	Freq. (MHz)	Q.P. Raw (dBuV)	AV. Raw (dBuV)	Q.P. Limit (dBuV)	AV. Limit (dBuV)	Q.P. Margin (dB)	AV. Margin (dB)	Note
	X.XX	43.95		87.00	74.00	-43.05		
F	Freq.: Emission frequency							
ŀ	Raw:	Uncorrec	ted Analyze	er / Receiver	r reading			
I	.imit:	Limit sta	ted in stand	ard				
ľ	Margin:	Reading	in reference	to limit				
ľ	Note:							
6	:	The emission level complied with the Average limits, with at least 2 dB margin, so no further recheck.						

7.4 TEST PROCEDURE OF RADIATED EMISSION

Procedure of Preliminary Test

- The equipment was set up as per the test configuration to simulate typical usage per the user's manual. When the EUT is a tabletop system, a wooden turntable with a height of 0.8 meters is used which is placed on the ground plane. When the EUT is a floor-standing equipment, it is placed on the ground plane which has a 3-12 mm non-conductive covering to insulate the EUT from the ground plane.
- Support equipment, if needed, was placed as per EN 55022.
- All I/O cables were positioned to simulate typical usage as per EN 55022.
- The EUT received AC power source, 230VAC/50Hz, from the outlet socket under the turntable. All support equipment received power from another socket under the turntable.
- The antenna was placed at 10 meter away from the EUT as stated in EN 55022. The antenna connected to the Spectrum Analyzer via a cable and at times a pre-amplifier would be used.
- The Analyzer / Receiver quickly scanned from 30MHz to 1000MHz. The EUT test program was started. Emissions were scanned and measured rotating the EUT to 360 degrees and positioning the antenna 1 to 4 meters above the ground plane, in both the vertical and the horizontal polarization, to maximize the emission reading level.
- The test mode(s) described in Item 3.2 were scanned during the preliminary test:
- After the preliminary scan, we found the test mode described in Item 3.2 producing the highest emission level.
- The EUT and cable configuration, antenna position, polarization and turntable position of the above highest emission level were recorded for the final test.



Procedure of Final Test

- EUT and support equipment were set up on the turntable as per the configuration with highest emission level in the preliminary test.
- The Analyzer / Receiver scanned from 30MHz to 1000MHz. Emissions were scanned and measured rotating the EUT to 360 degrees, varying cable placement and positioning the antenna 1 to 4 meters above the ground plane, in both the vertical and the horizontal polarization, to maximize the emission reading level.
- Recorded at least the six highest emissions. Emission frequency, amplitude, antenna position, polarization and turntable position were recorded into a computer in which correction factors were used to calculate the emission level and compare reading to the applicable limit and only Q.P. reading is presented.
- The test data of the worst-case condition(s) was recorded.

Data Sample:

Freq. (MHz)	Raw Data (dBuV)	Corr. Factor (dB/m)	Emiss. Level (dBuV/m)	Limits (dBuV/m)	Margin (dB)
XX.XX	14.00	12.20	26.20	40.00	-13.80

Freq.

= Emission frequency in MHz

1.	
Raw Data (dBuV)	= Uncorrected Analyzer / Receiver reading
Corr. Factor (dB/m)	= Antenna factor + Cable loss – Amplifier gain
Emiss. Level (dBuV/m)	= Raw reading converted to dBuV/m and CF added
Limit (dBuV/m)	= Limit stated in standard
Margin (dB)	= Reading in reference to limit
Р	= Peak Reading
Q	= Quasi-peak Reading
А	= Average Reading

Calculation Formula

Margin (dB) = Emiss. Level (dBuV/m) – Limits (dBuV/m) Emission Level (dBuV/m) = Raw Data (dBuV) + Corr. Factor (dB/m)

Date of Issue: November 29, 2004

7.5 TEST RESULTS

Line Conducted Emission

Model: ACP-2320

Temperature: 25°C

Tested by: Ethan Huang

Test Mode: Mode 1

Humidity: 57% RH

Test Results: Pass

Freq. (MHz)	Q.P. Raw (dBuV)	AVG Raw (dBuV)	Q.P. Limit (dBuV)	AVG Limit (dBuV)	Q.P. Margin (dB)	AVG Margin (dB)	NOTE
0.160	45.00		79.00	66.00	-34.00		L1
3.975	25.80		73.00	60.00	-47.20		L1
8.394	26.70		73.00	60.00	-46.30		L1
8.635	30.50		73.00	60.00	-42.50		L1
11.274	26.80		73.00	60.00	-46.20		L1
11.941	26.10		73.00	60.00	-46.90		L1
0.200	44.10		79.00	66.00	-34.90		L2
3.974	23.50		73.00	60.00	-49.50		L2
8.415	24.80		73.00	60.00	-48.20		L2
8.615	29.40		73.00	60.00	-43.60		L2
11.238	25.41		73.00	60.00	-47.59		L2
11.933	24.10		73.00	60.00	-48.90		L2

(The chart below shows the highest readings taken from the final data)

L1 = Line One (Live Line) / L2 = Line Two (Neutral Line)

Line Conducted Emission

Model: ACP-2320	Test Mode: Mode 4
Temperature: 22°C	Humidity: 61% RH
Tested by: Arno Hsieh	Test Results: Pass

(The chart below shows the highest readings taken from the final data)

Freq. (MHz)	Q.P. Raw (dBuV)	AVG Raw (dBuV)	Q.P. Limit (dBuV)	AVG Limit (dBuV)	Q.P. Margin (dB)	AVG Margin (dB)	NOTE
0.165	47.80		79.00	66.00	-31.20		L1
0.942	22.60		73.00	60.00	-50.40		L1
3.451	25.40		73.00	60.00	-47.60		L1
5.302	29.80		73.00	60.00	-43.20		L1
5.919	28.10		73.00	60.00	-44.90		L1
7.924	28.60		73.00	60.00	-44.40		L1
0.160	46.30		79.00	66.00	-32.70		L2
0.942	21.20		73.00	60.00	-51.80		L2
3.451	27.60		73.00	60.00	-45.40		L2
5.304	28.40		73.00	60.00	-44.60		L2
5.912	30.10		73.00	60.00	-42.90		L2
7.924	29.40		73.00	60.00	-43.60		L2

L1 = Line One (Live Line) / L2 = Line Two (Neutral Line)

Common Mode Conducted Emission

Model: ACP-2320	Test Mode: Mode 1
Temperature: 25°C	Humidity: 57% RH
Tested by: Ethan Huang	Test Results: Pass

(The chart below shows the highest readings taken from the final data)

Freq.	Q.P. Raw	AVG Raw	Q.P. Limit	AVG Limit	Q.P. Margin	AVG Margin	NOTE
(MHz)	(dBuV)	(dBuV)	(dBuV)	(dBuV)	(dB)	(dB)	
0.660	52.50		87.00	74.00	-34.50		10Base
2.204	44.80		87.00	74.00	-42.20		10Base
3.744	53.30		87.00	74.00	-33.70		10Base
5.295	53.50		87.00	74.00	-33.50		10Base
6.254	65.40		87.00	74.00	-21.60		10Base
7.582	54.80		87.00	74.00	-32.20		10Base
0.660	52.40		87.00	74.00	-34.60		100Base
1.023	46.70		87.00	74.00	-40.30		100Base
2.651	44.80		87.00	74.00	-42.20		100Base
5.294	59.40		87.00	74.00	-27.60		100Base
6.714	54.80		87.00	74.00	-32.20		100Base
7.944	55.80		87.00	74.00	-31.20		100Base

L1 = Line One (Live Line) / L2 = Line Two (Neutral Line)

Common Mode Conducted Emission

Model: ACP-2320	Test Mode: Mode 2
Temperature: 22°C	Humidity: 61% RH
Tested by: Arno Hsieh	Test Results: Pass

(The chart below shows the highest readings taken from the final data)

Freq. (MHz)	Q.P. Raw	AVG Raw	Q.P. Limit	AVG Limit	Q.P. Margin	AVG Margin	NOTE
	(dBuV)	(dBuV)	(dBuV)	(dBuV)	(dB)	(dB)	
0.660	53.60		87.00	74.00	-33.40		10Base
1.034	54.10		87.00	74.00	-32.90		10Base
3.864	49.80		87.00	74.00	-37.20		10Base
4.957	55.60		87.00	74.00	-31.40		10Base
6.914	56.40		87.00	74.00	-30.60		10Base
8.153	56.70		87.00	74.00	-30.30		10Base
	_	_			-	-	
0.660	54.20		87.00	74.00	-32.80		100Base
1.224	52.60		87.00	74.00	-34.40		100Base
2.631	48.10		87.00	74.00	-38.90		100Base
5.302	52.70		87.00	74.00	-34.30		100Base
5.914	53.30		87.00	74.00	-33.70		100Base
7.926	55.70		87.00	74.00	-31.30		100Base

L1 = Line One (Live Line) / L2 = Line Two (Neutral Line)

Radiated Emission (A)

Model: ACP-2320	Test Mode: Mode 1
Temperature: 25°C	Humidity: 63% RH
Detector Function: Quasi-peak.	Antenna: Vertical at 10m
Tested by: Ethan Huang	Test Results: Pass

Freq.	Raw	Corr.	Emiss.	Limits	Margin
(MHz)	Data (dBuV)	Factor (dB/m)	Level (dBuV/m)	(dBuV/m)	(dB)
84.81	22.4	13.4	35.8	40.0	-4.2
121.86	20.4	12.1	32.5	40.0	-7.5
	19.4	11.9		40.0	-8.7
151.40	13.8	12.6	26.4	40.0	-13.6
157.27	8.7	12.9	21.6	40.0	-18.4
166.66	15.8	13.0	28.8	40.0	-11.2
	10.4	13.8	24.2	40.0	- · -
	11.1	24.1		47.0	

Radiated Emission (B)

Model: ACP-2320	Test Mode: Mode 1
Temperature: 25°C	Humidity: 63% RH
Detector Function: Quasi-peak.	Antenna: Horizontal at 10m
Tested by: Ethan Huang	Test Results: Pass

======================================	Raw	Corr.	Emiss.	Limits	======================================
(MHz)	Data (dBuV)	Factor (dB/m)	Level (dBuV/m)	(dBuV/m)	(dB)
85.63	18.3	13.7	32.0	40.0	-8.0
	11.7	12.0	23.7	40.0	
	16.3	13.0	29.3	40.0	-10.7
199.79	11.8	13.8	25.6	40.0	-14.4
213.81	5.2	14.5	19.7	40.0	-20.3
333.37	13.0	17.1	30.1	47.0	-16.9
400.00	17.0	19.8	36.8	47.0	-10.2
464.47	12.5	23.4	35.9	47.0	-11.1

Radiated Emission (A)

Model: ACP-2320	Test Mode: Mode 4
Temperature: 20°C	Humidity: 60% RH
Detector Function: Quasi-peak.	Antenna: Vertical at 10m
Tested by: Arno Hish	Test Results: Pass

Freq.	Raw	Corr.	Emiss.	Limits	 Margin
(MHz)	Data (dBuV)	Factor (dB/m)	Level (dBuV/m)	(dBuV/m)	(dB)
45.60	19.9	13.3	33.2	40.0	-6.8
66.20	20.6	5.7	26.3	40.0	-13.7
125.54	11.0	11.9	22.9	40.0	-17.1
145.09	14.1	11.7	25.8	40.0	-14.2
200.09	13.6	10.8	24.4	40.0	-15.6
221.03	12.3	10.4	22.7	40.0	-17.3
265.21	9.5	15.1	24.6	47.0	-22.4
399.90	10.6	20.0	30.6	47.0	-16.4
466.30	8.1	19.7	27.8	47.0	-19.2
598.00	9.4	22.1	31.5	47.0	-15.5
995.70	.8	30.0	30.8	47.0	-16.2

Radiated Emission (B)

Model: ACP-2320	Test Mode: Mode 4
Temperature: 20°C	Humidity: 60% RH
Detector Function: Quasi-peak.	Antenna: Horizontal at 10m
Tested by: Arno Hsieh	Test Results: Pass

Freq.	Raw Data	Corr. Factor	Emiss. Level	Limits	Margin
(MHz)	(dBuV)	(dB/m)	(dBuV/m)	(dBuV/m)	(dB)
64.54	16.2	5.7	21.9	40.0	-18.1
85.20	19.3	8.1	27.4	40.0	-12.6
118.86	15.1	11.8	26.9	40.0	-13.1
166.03	10.6	10.4	21.0	40.0	-19.0
200.09	15.6	10.8	26.4	40.0	-13.6
219.91	11.9	10.4	22.3	40.0	-17.7
240.14	9.2	12.1	21.3	47.0	-25.7
266.93	12.3	15.3	27.6	47.0	-19.4
334.00	10.5	17.0	27.5	47.0	-19.5
399.00	13.2	20.0	33.2	47.0	-13.8
466.90	11.8	19.7	31.5	47.0	-15.5
598.00	7.4	22.1	29.5	47.0	-17.5
800.70	1.7	26.7	28.4	47.0	-18.6
863.30	1.0	28.7	29.7	47.0	-17.3

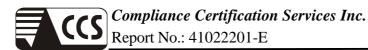


POWER HARMONICS TEST 8

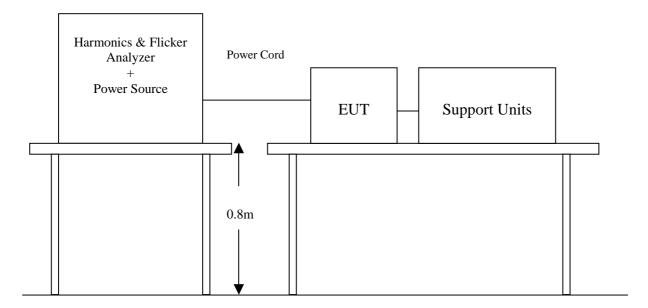
Port	:	AC mains
Basic Standard	:	EN 61000-3-2 (2000)
Limits	:	\Box CLASS A; \Box CLASS B; \Box CLASS C; \boxtimes CLASS D
Tested by	:	Ethan Huang / Arno Hsieh (Mode 1 / Mode 4)
Temperature	:	20°C / 26°C (Mode 1 / Mode 4)
Humidity	:	51% RH
Test Mode	:	1, 4

<u>Limit:</u>

Limits for Class A equipment			Limits for Class D equip	Limits for Class D equipment		
Harmonics Order n	Max. permissible harmonics current A	Harmonics Order n	Max. permissible harmonics current per watt mA/W	Max. permissible harmonics current A		
Od	ld harmonics		Odd Harmonics only			
3	2.30	3	3.4	2.30		
5	1.14	5	1.9	1.14		
7	0.77	7	1.0	0.77		
9	0.40	9	0.5	0.40		
11	0.33	11	0.35	0.33		
13	0.21	13	0.30	0.21		
15<=n<=39	0.15x15/n	15<=n<=39	3.85/n	0.15x15/n		
Eve	en harmonics					
2	1.08					
4	0.43					
6	0.30					
8<=n<=40	0.23x8/n					



Block Diagram of Test Setup:



Test Procedure:

- a. The EUT was placed on the top of a wooden table 0.8 meters above the ground and operated to produce the maximum harmonic components under normal operating conditions for each successive harmonic component in turn.
- b. The correspondent test program of test instrument to measure the current harmonics emanated from EUT is chosen. The measure time shall be not less than the time necessary for the EUT to be exercised.

Test Result : (See Appendix II for details)





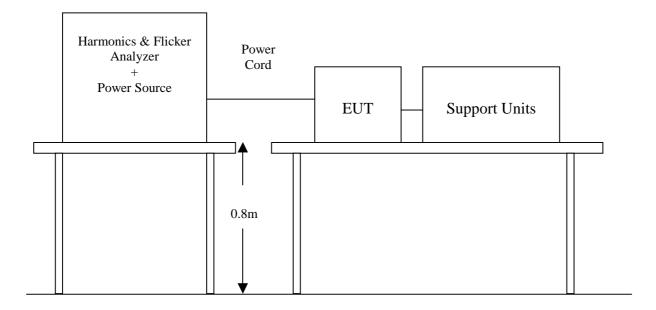
9 POWER VOLTAGE FLUCTUATION / FLICKER TEST

Port	: AC mains
Basic Standard	: EN 61000-3-3 (1995 + A1: 2001)
Limits	: §5 of EN 61000-3-3
Tested by	: Ethan Huang / Arno Hsieh (Mode 1 / Mode 4)
Temperature	: 26°C
Humidity	: 54% RH / 55% RH (Mode 1 / Mode 4)
Test Mode	: 1,4

Limit:

TEST ITEM	LIMIT	REMARK
P _{st}	1.0	P _{st} means short-term flicker indicator.
P _{lt}	0.65	P _{lt} means long-term flicker indicator.
T _{dt} (ms)	500	T_{dt} means maximum time that dt exceeds 3 %.
d _{max} (%)	4%	d _{max} means maximum relative voltage change.
dc (%)	3.3%	dc means relative steady-state voltage change

Block Diagram of Test Setup:



Test Procedure:

- a. The EUT was placed on the top of a wooden table 0.8 meters above the ground and operated to produce the most unfavorable sequence of voltage changes under normal operating conditions.
- b. During the flick measurement, the measure time shall include that part of whole operation cycle in which the EUT produce the most unfavorable sequence of voltage changes. The observation period for short-term flicker indicator is 10 minutes and the observation period for long-term flicker indicator is 2 hours.

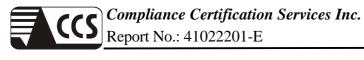
Test Result: (See Appendix II for details)

Test Parameter	Measurement Value	Limit	Result
\mathbf{P}_{st}	0.076	1.0	Pass
P _{lt}	0.076	0.65	Pass
T _{dt} (ms)	0	500	Pass
d _{max} (%)	0.22%	4%	Pass
dc (%)	0.06%	3.3%	Pass

Mode 1 Continue

Manual Switch

Test Parameter	Measurement Value	Limit	Result
P _{st}	0.072	1.0	Pass
P _{lt}	0.072	0.65	Pass
T _{dt} (ms)	0	500	Pass
d _{max} (%)	0%	4%	Pass
dc (%)	0%	3.3%	Pass



Mode 4 Continue

Test Parameter	Measurement Value	Limit	Result
P _{st}	0.076	1.0	Pass
P _{lt}	0.076	0.65	Pass
T _{dt} (ms)	0	500	Pass
d _{max} (%)	0.01%	4%	Pass
dc (%)	0.01%	3.3%	Pass

Manual Switch

Test Parameter	Measurement Value	Limit	Result
P _{st}	0.075	1.0	Pass
P _{lt}	0.076	0.65	Pass
T _{dt} (ms)	0	500	Pass
d _{max} (%)	0%	4%	Pass
dc (%)	0.09%	3.3%	Pass

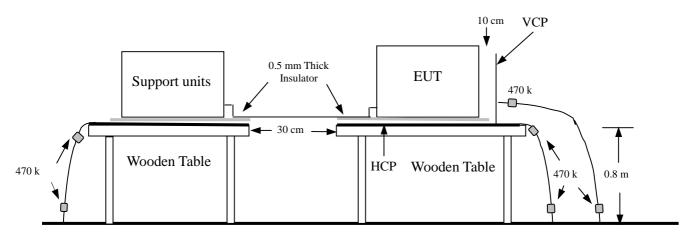


10 ELECTROSTATIC DISCHARGE (ESD) IMMUNITY TEST

Port	: Enclosure
Basic Standard	: IEC/EN 61000-4-2
Test Level	: $\pm 8 \text{ kV}$ (Air Discharge)
	± 4 kV (Contact Discharge)
	± 4 kV (Indirect Discharge)
Performance Criterion	: B (Standard Required)
Tested by	: Ethan Huang / Arno Hsien (Mode 1 / Mode 4)
Temperature	: 26°C / 23°C (Mode 1 / Mode 4)
Humidity	: 54% RH / 41% RH (Mode 1 / Mode 4)
Pressure	: 1019mbar /1007mbar (Mode 1 / Mode 4)
Test Mode	: 1, 4

Block Diagram of Test Setup:

(The 470 k ohm resistors are installed per standard requirement.)



Ground Reference Plane



Test Procedure:

- 1. The EUT was located 0.1 m minimum from all side of the HCP.
- 2. The indirect support units were located 1 m minimum away from the EUT, but direct support unit was/were located at same location as EUT on the HCP and keep at a distance of 10 cm with EUT.
- 3. A scroll 'H' test program was loaded and executed in Windows 2000 mode.
- 4. The EUT sent above message to monitor and LCD Panel of Notebook PC at remote side and related peripherals through the test.
- 5. Active the communication function if the EUT with such port(s).
- 6. As per the requirement of EN 55024; applying direct contact discharge at the sides other than front of EUT at minimum 50 discharges (25 positive and 25 negative) if applicable, can't be applied direct contact discharge side of EUT then the indirect discharge shall be applied. One of the test points shall be subjected to at least 50 indirect discharge (contact) to the front edge of horizontal coupling plane.
- 7. Other parts of EUT where it is not possible to perform contact discharge then selecting appropriate points of EUT for air discharge, a minimum of 10 single air discharges shall be applied.
- 8. The application of ESD to the contact of open connectors is not required.
- 9. The EUT direct connection units also need to be applied ESD at the port of EUT cable connected.
- 10. Putting a mark on EUT to show tested points. The following test condition was followed during the tests.

Note: As per IEC/EN 61000-4-2, two 470k bleed resistors cable is connected between the EUT and HCP during the test applicable for power ungrounded or battery operating unit only.

Amount of discharge	Voltage	Coupling	Result (Pass/Fail)
Mini 10 /Point	$\pm 8 \ kV$	Air Discharge	Pass
Mini 25 /Point	$\pm 4 \text{ kV}$	Contact Discharge	Pass
Mini 25 /Point	$\pm 4 \text{ kV}$	Indirect Discharge HCP	Pass
Mini 25 /Point	$\pm 4 \text{ kV}$	Indirect Discharge VCP (Right)	Pass
Mini 25 /Point	$\pm 4 \text{ kV}$	Indirect Discharge VCP (Left)	Pass

The electrostatic discharges were applied as follows:

For the tested points to EUT, please refer to attached page. (Blue arrow mark for Contact Discharge and red arrow mark for Air Discharge)

Performance & Result:

Criteria A:	The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.
Criteria B:	The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
Criteria C:	Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.

PASS FAIL
Observation: No function degraded during the tests.



The Tested Points of EUT

Photo 1 of 4







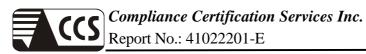


Photo 3 of 4



Photo 4 of 4

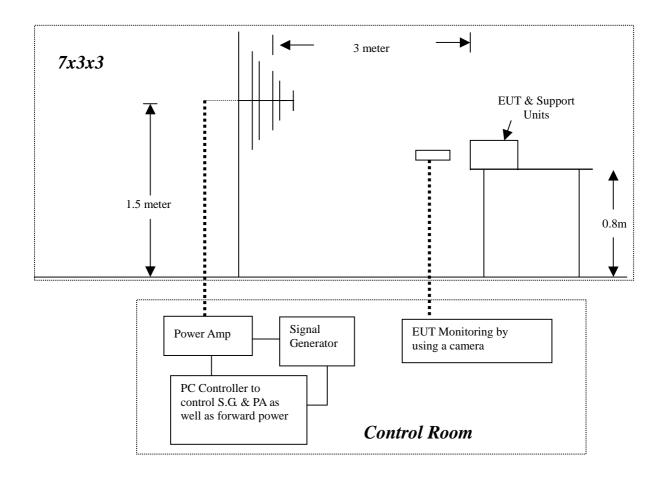




11 RADIATED ELECTROMAGNETIC FIELD IMMUNITY TEST

Port	: Enclosure
Basic Standard	: IEC/EN 61000-4-3
Requirements	: 10 V/m / with 80% AM. 1kHz Modulation. (Customer Required)
Performance Criterion	: A (Standard Required)
Tested by	: Ethan Huang / Arno Hsieh (Mode 1 / Mode 4)
Temperature	: 23°C / 24°C (Mode 1 / Mode 4)
Humidity	: 51% RH / 43% RH (Mode 1 / Mode 4)
Pressure	: 1019mbar / 1007mbar (Mode 1 / Mode 4)
Test Mode	: 1, 4

Block Diagram of Test Setup:





Test Procedure:

- 1. The EUT was located at the edge of supporting table keep 3 meter away from transmitting antenna, it just the calibrated square area of field uniformity. The support units were located outside of the uniformity area, but the cable(s) connected with EUT were exposed to the calibrated field as per IEC/EN 61000-4-3.
- 2. Setting the testing parameters of RS test software per IEC/EN 61000-4-3.
- 3. Performing the pre-test at each side of with double specified level (6V/m) at 4% steps.
- 4. From the result of pre-test in step 5, choice the worst side of EUT for final test from 80 MHz to 1000 MHz at 1% steps.
- 5. Recording the test result in following table.
- 6. It is not necessary to perform test as per annex A of EN 55024 if the EUT doesn't belong to ITE product.

Preliminary test conditions:

Test level	: 10V/m
Steps	:4% of fundamental
Dwell Time	: 3 sec

Range (MHz)	Field	Modulation	Polarity	Position	Result (Pass/Fail)
80-1000	10V/m	Yes	Н	Front	Pass
80-1000	10V/m	Yes	V	Front	Pass
80-1000	10V/m	Yes	Н	Right	Pass
80-1000	10V/m	Yes	V	Right	Pass
80-1000	10V/m	Yes	Н	Back	Pass
80-1000	10V/m	Yes	V	Back	Pass
80-1000	10V/m	Yes	Н	Left	Pass
80-1000	10V/m	Yes	V	Left	Pass

Final test conditions:

Test level	: 10V/m
Steps	: 1 % of fundamental
Dwell Time	: 3 sec

Range (MHz)	Field	Modulation	Polarity	Position	Result (Pass/Fail)
80-1000	10V/m	Yes	Н	Back	Pass
80-1000	10V/m	Yes	V	Back	Pass

Performance & Result:

Criteria A:	The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.
Criteria B:	The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
Criteria C:	Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.

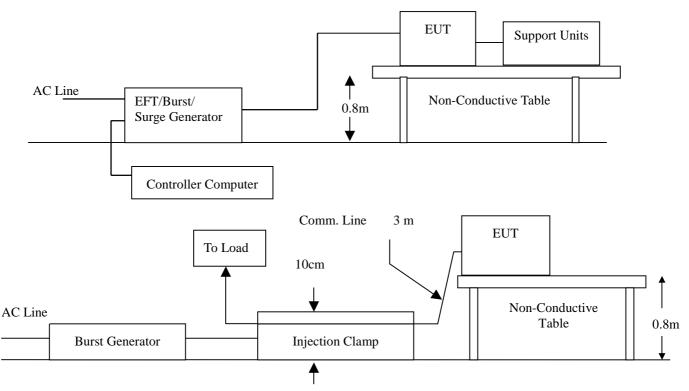
PASS FAIL					
Observation: No function degraded during the tests.					



12 FAST TRANSIENTS/BURST IMMUNITY TEST

Port	:	On Power Supply Line and LAN Cable		
Basic Standard	:	IEC/EN 61000-4-4		
Requirements	:	\pm 2 kV for Power Supply Line (Customer Required)		
		\pm 1kV for LAN Cable		
Performance Criteria	:	B (Standard Required)		
Tested by	:	Ethan Huang / Arno Hsieh (Mode 1 / Mode 4)		
Temperature	:	26°C / 23°C (Mode 1 / Mode 4)		
Humidity	:	54% RH / 41% RH (Mode 1 / Mode 4)		
Pressure	:	1019mbar / 1007mbar (Mode 1 / Mode 4)		
Test Mode	:	1, 4		

Block Diagram of Test Setup:



Test Procedure:

- 1. The EUT and support units were located on a wooden table 0.8 m away from ground reference plane.
- 2. A 1.0 meter long power cord was attached to EUT during the test.
- 3. The length of communication cable between communication port and clamp was keeping within 1 meter.
- 4. Injected test voltage to the EUT ports from minimum to standard request or client request.
- 5. Recording the test result as shown in following table.



Test conditions:

Impulse Frequency : 5kHzTr/Th: 5/50nsBurst Duration: 15msBurst Period: 3Hz

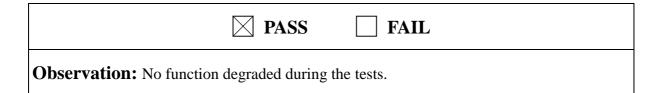
Inject Line	Voltage kV	Inject Method	Result (Pass/Fail)
L	± 2	Direct	Pass
N	± 2	Direct	Pass
PE	± 2	Direct	Pass
L + N	± 2	Direct	Pass
L + PE	± 2	Direct	Pass
N + PE	± 2	Direct	Pass
L + N + PE	± 2	Direct	Pass
RJ 45 Port (LAN Cable)	± 1	Clamp	Pass

Performance & Result:

🔀 Criteria A:

The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.

- **Criteria B:** The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
- **Criteria C:** Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.

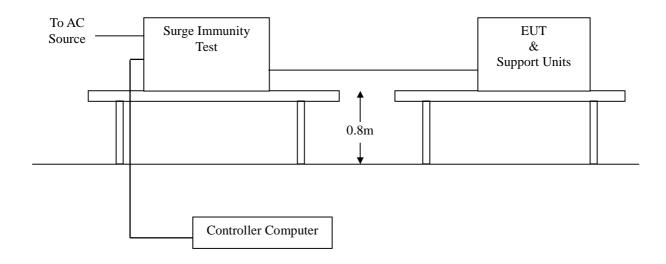




13 SURGE IMMUNITY TEST

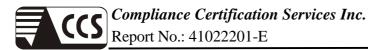
Port	:	Power Cord and LAN Cable
Basic Standard	:	IEC/EN 61000-4-5
Requirements	:	± 1 kV (Line to Line)
		± 2 kV (Line to Ground)
Performance Criteria	:	B (Standard Required)
Tested by	:	Ethan Huang / Arno Hsieh (Mode 1 / Mode 4)
Temperature	:	24°C / 23°C (Mode 1 / Mode 4)
Humidity	:	54% RH/ 41% RH (Mode 1 / Mode 4)
Pressure	:	1019mbar / 1007mbar (Mode 1 / Mode 4)
Test Mode	:	1, 4

Block Diagram of Test Setup:



<u>Test Procedure</u>:

- 1. The EUT and support units were located on a wooden table 0.8 m away from ground floor.
- 2. Injected test voltage to the EUT ports from minimum to standard request or client request.
- 3. Recording the test result as shown in following table.



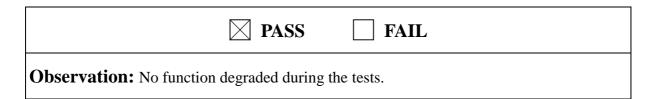
Test conditions:

Voltage Waveform	: 1.2/50 <i>us</i>
Current Waveform	: 8/20 <i>u</i> s
Polarity	: Positive/Negative
Phase angle	$: 0^{\circ}, 90^{\circ}, 270^{\circ}$
Number of Test	: 5

Coupling Line	Voltage (kV)	Polarity	Coupling Method	Result (Pass/Fail)
L1-L2	1	Positive	Capacitive	Pass
L1-PE	2	Positive	Capacitive	Pass
L2-PE	2	Positive	Capacitive	Pass
L1-L2	1	Negative	Capacitive	Pass
L1-PE	2	Negative	Capacitive	Pass
L2-PE	2	Negative	Capacitive	Pass

Performance & Result:

- Criteria A: The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.
- **Criteria B:** The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
 - **Criteria C:** Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.



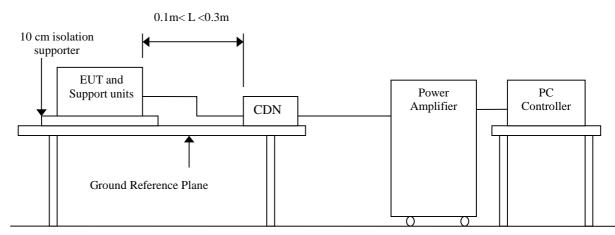


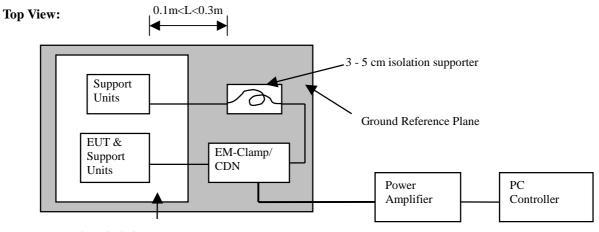
14 CONDUCTED DISTURBANCE/INDUCED RADIO-FREQUENCY FIELD IMMUNITY TEST

Port	: AC Port and Signal LAN Cable		
Basic Standard	: IEC/EN 61000-4-6		
Requirements	: 10 V with 80% AM. 1kHz Modulation. (Customer Required)		
Injection Method	: CDN-M3 for Power Cord		
	CDN-T4 for LAN Cable		
Performance Criterior	• : A (Standard Required)		
Tested by	: Ethan Huang / Arno Hsieh (Mode 1 / Mode 4)		
Temperature	: 23°C / 24°C (Mode 1 / Mode 4)		
Humidity	: 51% RH/ 43% RH (Mode 1 / Mode 4)		
Pressure	: 1019mbar / 1007mbar (Mode 1 / Mode 4)		
Test Mode	: 1,4		

Block Diagram of Test Setup:

Side View:







Test Procedure:

- 1. The EUT and support units were located at a ground reference plane with the interposition of a 0.1 m thickness insulating support and the CDN was located on GRP directly.
- 2. Setting the testing parameters of CS test software as per IEC/EN 61000-4-6.
- 3. Recording the test result in following table.

Test conditions:

Frequency Range	: 0.15MHz-80MHz
Frequency Step	:1% of fundamental
Dwell Time	: 3 sec

Range (MHz)	Field	Modulation	Result (Pass/Fail)
0.15-80	10V	Yes	Pass

Performance & Result:

- Criteria A: The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.
- **Criteria B:** The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
- **Criteria C:** Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.

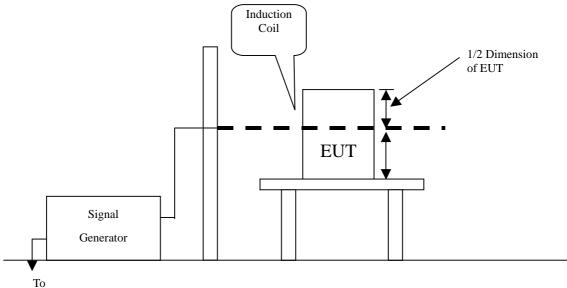
PASS	FAIL	
Observation: No function degraded during	the tests.	



15 POWER FREQUENCY MAGNETIC FIELD IMMUNITY TEST

Port	: Enclosure
Basic Standard	: IEC/EN 61000-4-8
Requirements	: 30 A/m (Customer Required)
Performance Criterion	: A (Standard Required)
Tested by	: Ethan Huang / Arno Hsieh (Mode 1 / Mode 4)
Temperature	: 26°C / 23°C (Mode 1 / Mode 4)
Humidity	: 51% RH/ 41% RH (Mode 1 / Mode 4)
Pressure	: 1019mbar / 1007mbar (Mode 1 / Mode 4)
Test Mode	: 1, 4

Block Diagram of Test Setup:



Earth Ground

Test Procedure:

- 1. The EUT and support units were located on Ground Reference Plane with the interposition of a 0.1 m thickness insulation support.
- 2. Putting the induction coil on horizontal direction. (X direction)
- 3. Rotating the induction coil by 90° (Y direction)
- 4. Rotating the induction coil by 90° again (Z direction)
- 5. Recording the test result as shown in following table.



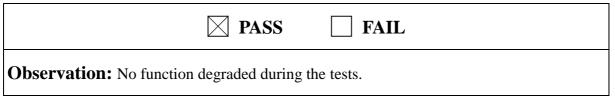
Test conditions:

Field Strength:	30A/m
Power Freq.:	50Hz
Orientation:	X, Y, Z

Orientation	Field	Result (Pass/Fail)	Remark
Х	30A/m	Pass	
Y	30A/m	Pass	
Z	30A/m	Pass	

Performance & Result:

Criteria A:	The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.
Criteria B:	The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
Criteria C:	Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.





16 VOLTAGE DIPS / SHORT INTERRUPTIONS

Port :	AC mains
--------	----------

Basic Standard : IEC/EN 61000-4-11

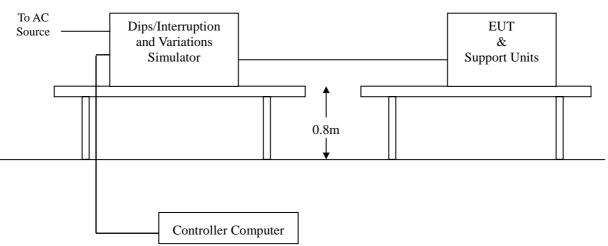
Requirement : PHASE ANGLE 0, 45, 90, 135, 180, 225, 270, 315 degrees

Voltage	Test Level % U _T	Reduction (%)	Duration (periods)	Performance Criteria
Dips	<5	>95	0.5	В
	70	30	25	С

Voltage	Test Level	Reduction	Duration (periods)	Performance
Interceptions	% U _T	(%)		Criteria
interceptions	<5	>95	250	С

Test Interval	: Min. 10 sec.
Tested by	: Ethan Huang / Arno Hsieh (Mode 1 / Mode 4)
Temperature	: 24°C / 23°C (Mode 1 / Mode 4)
Humidity	: 54% RH/ 41% RH (Mode 1 / Mode 4)
Pressure	: 1019mbar / 1007mbar (Mode 1 / Mode 4)
Test Mode	: 1,4

Block Diagram of Test Setup:



Test Procedure:

- 1. The EUT and support units were located on a wooden table, 0.8 m away from ground floor.
- 2. Setting the parameter of tests and then Perform the test software of test simulator.
- 3. Conditions changes to occur at 0 degree crossover point of the voltage waveform.
- 4. Recording the test result in test record form.



Test conditions

The duration with a sequence of three dips/interruptions with interval of 10 s minimum (Between each test event)

Voltage Dips:

Test Level % U _T	Reduction (%)	Duration (periods)	Observation	Meet Performance Criteria	
0	100	0.5	Normal	А	
70	30	25	Normal	А	

Voltage Interruptions:

Test Level % U _T	Reduction (%)	Duration (periods)	Observation	Meet Performance Criteria
0	100	250	EUT shut down but can be recovered by manual, as the events disappear.	

Normal: No any functions degrade during and after the test.

Performance & Result:

Criteria A:	The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.						
Criteria B:	The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.						
Criteria C:	Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.						

FAIL

PASS



APPENDIX I - PHOTOGRAPHS OF TEST SETUP

LINE CONDUCTED EMISSION TEST (EN 55022)







COMMON MODE CONDUCTED EMISSION TEST





RADIATED EMISSION TEST (EN 55022)







POWER HARMONIC & VOLTAGE FLUCTUATION / FLICKER TEST





ELECTROSTATIC DISCHARGE TEST

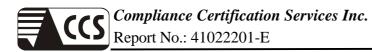






RADIATED ELECTROMAGNETIC FIELD TEST

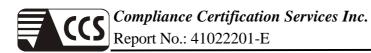




FAST TRANSIENTS/BURST TEST







SURGE IMMUNITY TEST





CONDUCTED DISTURBANCE, INDUCED BY RADIO-FREQUENCY FIELDS TEST





POWER FREQUENCY MAGNETIC FIELD IMMUNITY TEST



VOLTAGE DIPS / INTERRUPTION TEST



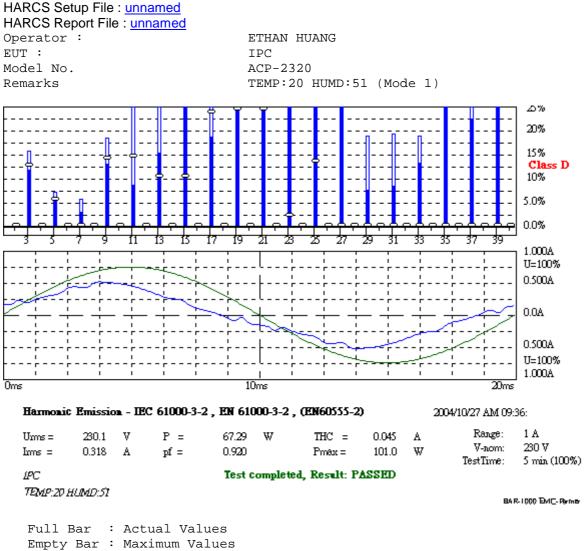


APPENDIX II – TEST RESULT OF EN 61000-3-2/-3

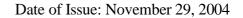
Harmonic Emission - IEC 61000-3-2 , EN 61000-3-2 , (EN60555-2)

Comply: IEC 61000-3-2 Ed.2.1 :2001 (incl. Amd.14) - IEC 61000-4-7 Ed.1.0 :1991

ADVANTECH



Blue : Current , Green : Voltage , Red : Failed



ADVANTECH

CCS

Date : 2004/10/27 AM 09:36: V3.15

File : Operator : EUT : Model No. Remarks Urms = 230.1V Freq = 49.987 Range: 1 A Irms = 0.318A Ipk = 0.529A cf = 1.664 P = 67.29W Pap = 73.14VA pf = 0.920 THDi = 14.2 % THDu = 0.10 % Class D Test - Time : 5min (100 %) Limit Reference: Pmax = 101.05W

Test completed, Result: PASSED

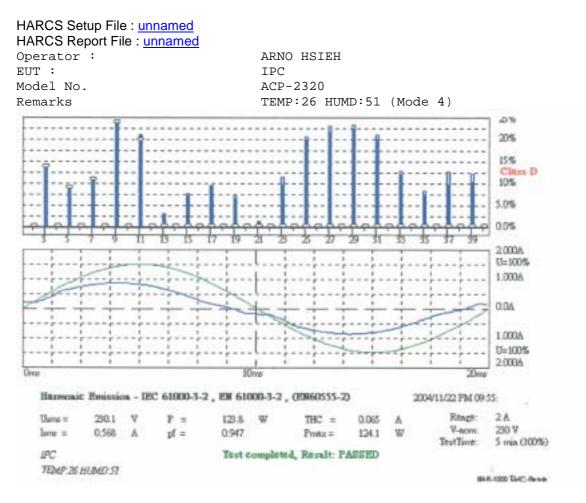
Order	Freq. [Hz]	Imax [A]	Imax% [%]	Imax%L [%]	Limit [A]	Status	Vrms [V]	Limit [V]	Status
1	50	0.4530	142.51				230.13	0.0000	
2	100		0.3456				0.1227		
3	150	0.0529	16.647	15.403	0.3436		0.0000		
4	200	0.0004	0.1152				0.0000	0.4663	
5	250		4.1667	6.8986	0.1920		0.0000		
6	300	0.0003					0.0000		
7	350	0.0054	1.7089	5.3758	0.1010		0.0000		
8	400	0.0002					0.0000	0.4663	
9	450		2.8994	18.242	0.0505		0.0000		
10	500	0.0004					0.0000	0.4663	
11	550	0.0093		26.232	0.0354		0.0000		
12	600	0.0004					0.0000	0.2209	
13	650		2.3426	24.883	0.0299		0.0000		
14	700		0.1344				0.0000		
15	750	0.0085		32.712	0.0259		0.0000		
16	800		0.1152				0.0000	0.2209	
17	850	0.0114	3.5906	49.875	0.0229		0.0000	0.2209	
18	900		0.1152				0.0000	0.2209	
19	950	0.0079		38.752	0.0205		0.0000		
20	1000		0.1344				0.0000	0.2209	
21	1050		2.8226	48.432	0.0185		0.0000		
22	1100	0.0003					0.0000	0.2209	
23	1150	0.0050	1.5745	29.589	0.0169		0.0000		
24	1200	0.0003	0.0960				0.0000	0.2209	
25	1250	0.0059	1.8625	38.046	0.0156		0.0000	0.2209	
26	1300	0.0003	0.0960				0.0000	0.2209	
27	1350	0.0042	1.3057	28.805	0.0144		0.0000		
28	1400	0.0002	0.0768				0.0000	0.2209	
29	1450		0.7873	18.654	0.0134		0.0000	0.2209	
30	1500	0.0002					0.0000	0.2209	
31	1550	0.0024		18.968	0.0125		0.0000	0.2209	
32	1600	0.0002	0.0576				0.0000	0.2209	
33	1650	0.0022	0.6912	18.639	0.0118		0.0000	0.2209	
34	1700	0.0002	0.0768				0.0000	0.2209	
35	1750	0.0040	1.2673	36.242	0.0111		0.0000	0.2209	
36	1800	0.0002	0.0576				0.0000	0.2209	
37	1850	0.0040	1.2673	38.313	0.0105		0.0000		
38	1900		0.0384	00 146	0 01 00		0.0000	0.2209	
39	1950	0.0028		28.146	0.0100		0.0000	0.2209	
40	2000	0.0001	0.0384				0.0000	0.2209	



Harmonic Emission - IEC 61000-3-2, EN 61000-3-2, (EN60555-2)

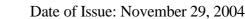
Comply: IEC 61000-3-2 Ed.2.1 :2001 (incl. Amd.14) - IEC 61000-4-7 Ed.1.0 :1991

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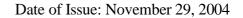


Full Bar : Actual Values
Empty Bar : Maximum Values
Blue : Current , Green : Voltage , Red : Failed

S



ADVANTECH Date : 2004/11/22 PM 09:55: V3.15 File : Operator : ARNO HSIEH EUT : IPC Model No. ACP-2320 TEMP:26 HUMD:51 (MODE 4) Remarks Urms = 230.1V Freq = 49.987 Range: 2 A Irms = 0.568A Ipk = 0.884A cf = 1.555= 123.8W Pap = 130.8VA pf = 0.947 Ρ THDi = 11.5 % THDu = 0.10 % Class D Test - Time : 5min (100 %) Limit Reference: Pmax = 104.12WTest completed, Result: PASSED Order Imax%L Limit Freq. Imax Imax% Status [Hz] [A] [%] [%] [A] 1 50 0.5963 104.92 0.0011 0.1933 2 100 0.0577 10.159 13.682 0.4420 3 150 4 200 0.0007 0.1289 5 250 0.0209 3.6727 8.8512 0.2358 б 300 0.0001 0.0215 0.0132 2.3196 10.621 0.1241 7 350 0.0002 0.0430 8 400 9 450 0.0146 2.5773 23.603 0.0621 0.0002 0.0430 10 500 11 550 0.0090 1.5893 20.793 0.0434 12 600 0.0002 0.0430 13 650 0.0010 0.1718 2.6566 0.0368 14 700 0.0000 0.0000 15 750 0.0023 0.4081 7.2802 0.0319 16 800 0.0001 0.0215 17 0.0026 0.4510 9.1194 0.0281 850 0.0001 0.0215 18 900 0.0017 0.3007 6.7948 0.0252 19 950 0.0000 0.0000 20 1000 0.0002 0.0430 1.0729 0.0228 21 1050 22 1100 0.0003 0.0000 23 1150 0.0023 0.4081 11.163 0.0208 24 1200 0.0001 0.0215 25 1250 0.0039 0.6873 20.436 0.0191 26 1300 0.0001 0.0215 27 0.0040 0.7088 22.760 0.0177 1350 28 0.0001 0.0215 1400 29 0.0038 0.6658 22.964 0.0165 1450 30 1500 0.0001 0.0215 31 1550 0.0032 0.5584 20.589 0.0154 32 1600 0.0001 0.0215 33 0.0018 0.3222 12.645 0.0145 1650 34 0.0001 0.0215 1700 35 0.0011 0.1933 8.0465 0.0137 1750 0.0001 0.0215 36 1800 37 0.0016 0.2792 12.287 0.0129 1850 0.0001 0.0215 38 1900 39 0.0015 0.2577 11.955 0.0123 1950 40 2000 0.0001 0.0215



ADVANTECH

Date : 2004/10/27 AM 09:36: V3.15

File : Operator : EUT : Model No. Remarks Urms = 230.1V Freq = 49.987 Range: 1 A Irms = 0.318A Ipk = 0.529A cf = 1.664 P = 67.29W Pap = 73.14VA pf = 0.920 THDi = 14.2 % THDu = 0.10 % Class D Test - Time : 5min (100 %) Limit Reference: Pmax = 101.05W

Test completed, Result: PASSED

Order	Freq. [Hz]	Imax [A]	Imax% [%]	Imax%L [%]	Limit [A]	Status	Vrms [V]	Limit [V]	Status
1	50	0.4530	142.51				230.13	0.0000	
2	100		0.3456				0.1227		
3	150	0.0529	16.647	15.403	0.3436		0.0000		
4	200	0.0004	0.1152				0.0000	0.4663	
5	250		4.1667	6.8986	0.1920		0.0000		
6	300	0.0003					0.0000		
7	350	0.0054	1.7089	5.3758	0.1010		0.0000		
8	400	0.0002					0.0000	0.4663	
9	450		2.8994	18.242	0.0505		0.0000		
10	500	0.0004					0.0000	0.4663	
11	550	0.0093		26.232	0.0354		0.0000		
12	600	0.0004					0.0000	0.2209	
13	650		2.3426	24.883	0.0299		0.0000		
14	700		0.1344				0.0000		
15	750	0.0085		32.712	0.0259		0.0000		
16	800		0.1152				0.0000	0.2209	
17	850	0.0114	3.5906	49.875	0.0229		0.0000	0.2209	
18	900		0.1152				0.0000	0.2209	
19	950	0.0079		38.752	0.0205		0.0000		
20	1000		0.1344				0.0000	0.2209	
21	1050		2.8226	48.432	0.0185		0.0000		
22	1100	0.0003					0.0000	0.2209	
23	1150	0.0050	1.5745	29.589	0.0169		0.0000		
24	1200	0.0003	0.0960				0.0000	0.2209	
25	1250	0.0059	1.8625	38.046	0.0156		0.0000	0.2209	
26	1300	0.0003	0.0960				0.0000	0.2209	
27	1350	0.0042	1.3057	28.805	0.0144		0.0000		
28	1400	0.0002	0.0768				0.0000	0.2209	
29	1450		0.7873	18.654	0.0134		0.0000	0.2209	
30	1500	0.0002					0.0000	0.2209	
31	1550	0.0024		18.968	0.0125		0.0000	0.2209	
32	1600	0.0002	0.0576				0.0000	0.2209	
33	1650	0.0022	0.6912	18.639	0.0118		0.0000	0.2209	
34	1700	0.0002	0.0768				0.0000	0.2209	
35	1750	0.0040	1.2673	36.242	0.0111		0.0000	0.2209	
36	1800	0.0002	0.0576				0.0000	0.2209	
37	1850	0.0040	1.2673	38.313	0.0105		0.0000		
38	1900		0.0384	00 146	0 01 00		0.0000	0.2209	
39	1950	0.0028		28.146	0.0100		0.0000	0.2209	
40	2000	0.0001	0.0384				0.0000	0.2209	

```
Date : 2004/10/26 AM 11:24: V3.15
ADVANTECH
File :
Operator :
                          ETHAN HUANG
EUT :
                           IPC
Model No.
                            ACP-2320 (Mode 1)
                            TEMP:26 HUMD:54 (Continue)
Remarks
Urms = 230.1V Freq = 49.987 Range: 1 A
Irms = 0.574A Ipk = 0.906A cf = 1.577
P = 128.5W Pap = 132.1VA pf = 0.973
Test - Time : 1 x 10min = 10min ( 100 %)
LIN (Line Impedance Network) : SLIN 0.240hm +j0.150hm N:0.160hm +j0.100hm
              Plt : 0.65 Pst : 1.00
Limits :
              dmax : 4.00 % dc : 3.30 %
              dtLim: 3.30 % dt>Lim: 500ms
Test completed, Result: PASSED
Plt = 0.076
             dmax dc dt>Lim Fail
       Pst
              [%] [%]
                           [ms]
1
   0.076 0.220 0.060 0.000
```



```
Date : 2004/10/26 AM 11:44: V3.15
ADVANTECH
File :
Operator :
                          ETHAN HUANG
EUT :
                            IPC
Model No.
                            ACP-2320 (Mode 1)
                            TEMP:26 HUMD:54 (Manual Switch)
Remarks
Urms = 230.1V Freq = 49.974 Range: 1 A
Irms = 0.568A Ipk = 0.891A cf = 1.568
P = 127.0W Pap = 130.8VA pf = 0.971
Test - Time : 1 x 10min = 10min ( 100 %)
LIN (Line Impedance Network) : SLIN 0.240hm +j0.150hm N:0.160hm +j0.100hm
              Plt : 0.65 Pst : 1.00
Limits :
              dmax : 4.00 % dc : 3.30 %
              dtLim: 3.30 % dt>Lim: 500ms
Test completed, Result: PASSED
Plt = 0.072
             dmax dc dt>Lim Fail
       Pst
              [%]
                   [ % ]
                            [ms]
1
   0.072 0.000 0.000 0.000
```



Date : 2004/11/22 PM 10:16: V3.15 ADVANTECH File : Operator : ARNO HSIEH EUT : IPC Model No. ACP-2320 (Mode 4) Remarks TEMP:26 HUMD:55 (Continue) Urms = 230.1V Freq = 49.987 Range: 2 A Irms = 0.572A Ipk = 0.890A cf = 1.555 P = 124.9W Pap = 131.7VA pf = 0.948 Test - Time : 1 x 10min = 10min (100 %) LIN (Line Impedance Network) : SLIN 0.240hm +j0.150hm N:0.160hm +j0.100hm Plt : 0.65 Pst : 1.00 Limits : dmax : 4.00 % dc : 3.30 % dtLim: 3.30 % dt>Lim: 500ms Test completed, Result: PASSED Plt = 0.072dmax dc dt>Lim Fail Pst [%] [%] [ms] 1 0.072 0.000 0.010 0.000



Date : 2004/11/22 PM 10:28: V3.15 ADVANTECH File : Operator : ARNO HSIEH EUT : IPC Model No. ACP-2320 (Mode 4) Remarks TEMP:26 HUMD:55 (Manual Switch) Urms = 230.1V Freq = 49.987 Range: 2 A Irms = 0.569A Ipk = 0.887A cf = 1.557 P = 124.1W Pap = 131.0VA pf = 0.948 Test - Time : 1 x 10min = 10min (100 %) LIN (Line Impedance Network) : SLIN 0.240hm +j0.150hm N:0.160hm +j0.100hm Plt : 0.65 Pst : 1.00 Limits : dmax : 4.00 % dc : 3.30 % dtLim: 3.30 % dt>Lim: 500ms Test completed, Result: PASSED Plt = 0.076dmax dc dt>Lim Fail Pst [%] [%] [ms] 1 0.075 0.000 0.090 0.000